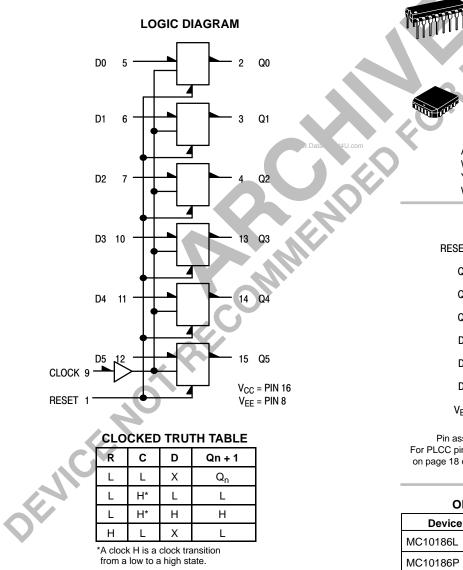
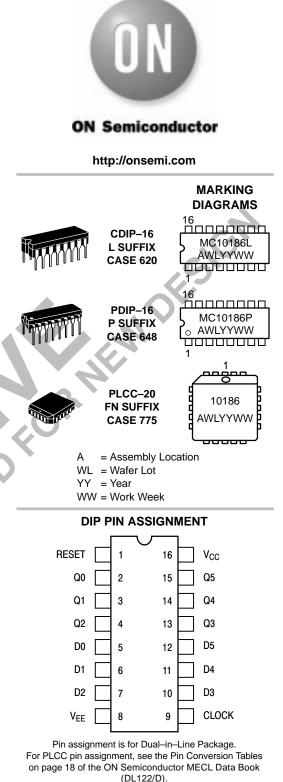
# Hex D Master-Slave Flip-Flop with Reset

The MC10186 contains six high–speed, master slave type "D" flip–flops. Clocking is common to all six flip–flops. Data is entered into the master when the clock is low. Master to slave data transfer takes place on the positive–going Clock transition. Thus, outputs may change only on a positive–going Clock transition. A change in the information present at the data (D) input will not affect the output information any other time due to the master–slave construction of this device. <u>A COMMON RESET IS INCLUDED IN THIS CIRCUIT.</u> RESET ONLY FUNCTIONS WHEN CLOCK IS LOW.

- $P_D = 460 \text{ mW typ/pkg}$  (No Load)
- $f_{toggle} = 150 \text{ MHz (typ)}$
- $t_r, t_f = 2.0 \text{ ns typ} (20\% 80\%)$





#### **ORDERING INFORMATION**

Device	Package	Shipping
MC10186L	CDIP-16	25 Units / Rail
MC10186P	PDIP-16	25 Units / Rail
MC10186FN	PLCC-20	46 Units / Rail

## **ELECTRICAL CHARACTERISTICS**

		Pin		Test Limits       -30°C     +25°C		+85°C		4		
		Under				+25°C				4
Characteristic	Symbol	Test	Min	Max	Min	Тур	Max	Min	Max	Un
Power Supply Drain Current	١ <sub>E</sub>	8		121		88	110		121	mA
Input Current	I <sub>inH</sub>	5		350			220		220	μAc
		9 1		495 920			310 575		310 575	
	l <sub>inL</sub>	5	0.5		0.5			0.3		μΑσ
Output Voltage Logic 1	V <sub>OH</sub>	2†	-1.060	-0.890	-0.960		-0.810	-0.890	-0.700	Vd
1 0 0	on	15†	-1.060	-0.890	-0.960		-0.810	-0.890	-0.700	
Output Voltage Logic 0	V <sub>OL</sub>	2†	-1.890	-1.675	-1.850		-1.650	-1.825	-1.615	Vd
<b>-</b>		15†	-1.890	-1.675	-1.850		-1.650	-1.825	-1.615	
Threshold Voltage Logic 1	V <sub>OHA</sub>	2† 15†	-1.080 -1.080		-0.980 -0.980			-0.910 -0.910		Vd
Threshold Voltage Logic 0	V <sub>OLA</sub>	2†		-1.655			-1.630		-1.595	Vd
	VOLA	15†		-1.655			-1.630		-1.595	1
Switching Times (50 $\Omega$ Load)										ns
Propagation Delay	t <sub>1+3-</sub>	3	1.6	4.6	1.6	2.5	4.5	1.6	5.0	
	t <sub>1+4-</sub>	4	1.6	4.6	1.6	2.5	4.5	1.6	5.0	
	t <sub>9+2+</sub> t <sub>9+2–</sub>	2 2	1.6 1.6	4.6 4.6	1.6 1.6	3.5 3.5	4.5 4.5	1.6 1.6	5.0 5.0	
Rise Time (20 to 80%)		2	1.0	4.1	1.1	1.8	4.0	1.1	4.4	
Fall Time (20 to 80%)	t <sub>2+</sub> t <sub>2-</sub>	2	1.0	4.1	1.1	1.8	4.0	1.1	4.4	
Setup Time	t <sub>setup</sub>	2	2.5		2.5	2.5		2.5		ns
Hold Time	t <sub>hold</sub>	2	1.5		1.5	-1.5		1.5		n
Toggle Frequency (Max)	f <sub>tog</sub>	2	125		125	150		125		MH
<b>DEVICE</b> NS										

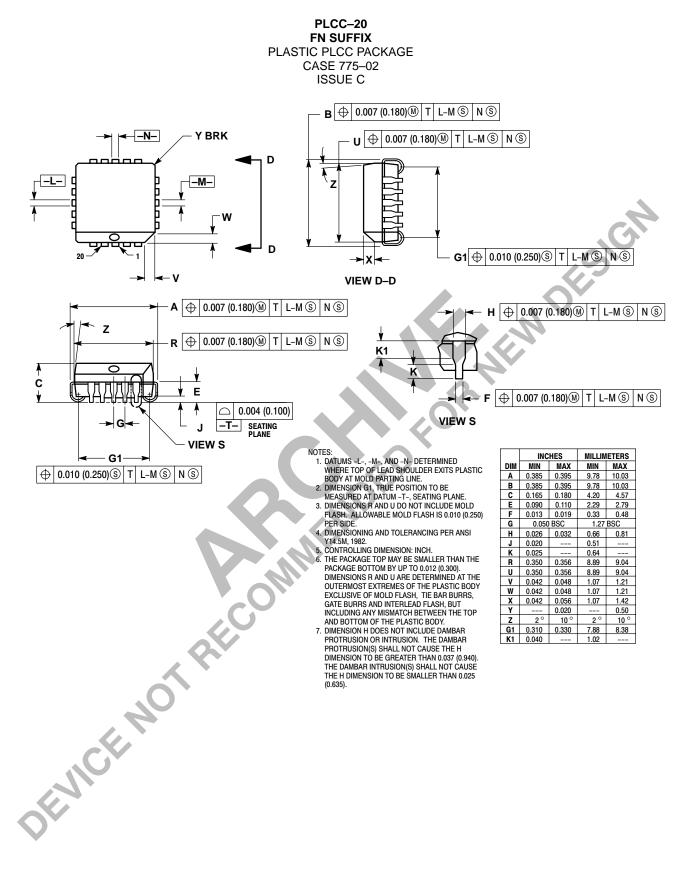
### ELECTRICAL CHARACTERISTICS (continued)

					TEST VOL	TAGE VALU	ES (Volts)		
		@ Test Te	mperature	V <sub>IHmax</sub>	V <sub>ILmin</sub>	V <sub>IHAmin</sub>	V <sub>ILAmax</sub>	V <sub>EE</sub>	
			–30°C	-0.890	-1.890	-1.205	-1.500	-5.2	
			+25°C	-0.810	-1.850	-1.105	-1.475	-5.2	
			+85°C	-0.700	-1.825	-1.035	-1.440	-5.2	
		Pin	TEST VOLTAGE APPLIED TO PINS LISTED BELOW						
Characteristic		Symbol	Under Test	V <sub>IHmax</sub>	V <sub>ILmin</sub>	V <sub>IHAmin</sub>	V <sub>ILAmax</sub>	V <sub>EE</sub>	(V <sub>CC</sub> ) Gnd
Power Supply Drain C	Current	Ι <sub>Ε</sub>	8					8	16
Input Current		l <sub>inH</sub>	5 9 1	5 9 1				8 8 8	16 16 16
		I <sub>inL</sub>	5		5			8	16
Output Voltage	Logic 1	V <sub>OH</sub>	2† 15†	5 12				8 8	16 16
Output Voltage	Logic 0	V <sub>OL</sub>	2† 15†		5 12			8 8	16 16
Threshold Voltage	Logic 1	V <sub>OHA</sub>	2† 15†			5 12		8 8	16 16
Threshold Voltage	Logic 0	V <sub>OLA</sub>	2† 15†				5 12	8 8	16 16
Switching Times	(50 $\Omega$ Load)			+1.11Vdc	+0.31V	Pulse In	Pulse Out	–3.2 V	+2.0 V
Propagation Delay		t <sub>1+3</sub> _ t <sub>1+4</sub> _ t <sub>9+2+</sub> t <sub>9+2</sub> _	3 4 2 2	6 7		1, 9 1, 9 5, 9 5, 9	3 4 2 2	8 8 8 8	16 16 16 16
Rise Time	(20 to 80%)	t <sub>2+</sub>	2		$\mathbf{O}$	5, 9	2	8	16
Fall Time	(20 to 80%)	t <sub>2-</sub>	2			5, 9	2	8	16
Setup Time		t <sub>setup</sub>	2			5, 9	2	8	16
Hold Time		t <sub>hold</sub>	2			5, 9	2	8	16
Toggle Frequency (Ma	ax)	f <sub>tog</sub>	2					8	16

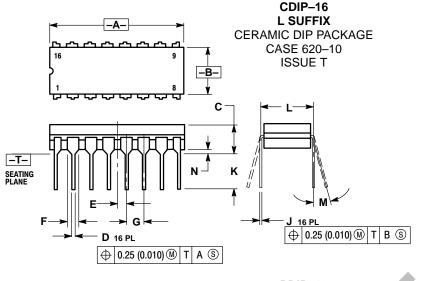
 $\dagger$  Output level to be measured after clock pulse. VII appears at clock input (Pin 9).

Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to -2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

#### PACKAGE DIMENSIONS



## PACKAGE DIMENSIONS



NOTES:

DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH.
DIMENSION L TO CENTER OF LEAD WHEN FOOMED DRAWLES

DIMENSION LTO CENTER OF LEAD WHEN FORMED PARALLEL.
DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.750	0.785	19.05	19.93	
В	0.240	0.295	6.10	7.49	
С		0.200		5.08	
D	0.015	0.020	0.39	0.50	
Е	0.050 BSC		1.27 BSC		
F	0.055	0.065	1.40	1.65	
G	0.100 BSC		2.54 BSC		
Н	0.008	0.015	0.21	0.38	
Κ	0.125	0.170	3.18	4.31	
L	0.300 BSC		7.62 BSC		
Μ	0 °	15 °	0 °	15°	
Ν	0.020	0.040	0.51	1.01	

-A-<u>ሳ ስ ስ ስ</u> 16 в 0 L  $\Box \Box$ ι, հո - C S -T- SEATING PLANE H G A ® **D** 16 PL

PDIP-16 **P SUFFIX** PLASTIC DIP PACKAGE CASE 648-08 ISSUE R

NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL. 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH. 5. ROUNDED CORNERS OPTIONAL

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.740	0.770	18.80	19.55	
В	0.250	0.270	6.35	6.85	
C	0.145	0.175	3.69	4.44	
D	0.015	0.021	0.39	0.53	
F	0.040	0.70	1.02	1.77	
G	0.100 BSC		2.54 BSC		
Н	0.050 BSC		1.27 BSC		
J	0.008	0.015	0.21	0.38	
K	0.110	0.130	2.80	3.30	
L	0.295	0.305	7.50	7.74	
Μ	0° 10°		0 °	10 °	
S	0.020	0.040	0.51	1.01	

## **Notes**

DEWCE NOT RECOMMENDED FOR MENDESIGN

## **Notes**

DEWCE NOT RECOMMENDED FOR MENDESIGN

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